**BLF278** 

VHF push-pull power MOS transistor Rev. 5 — 1 September 2015



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Ampleon

#### FEATURES

- High power gain
- · Easy power control
- Good thermal stability
- Gold metallization ensures excellent reliability.

#### APPLICATIONS

• Broadcast transmitters in the VHF frequency range.

#### DESCRIPTION

Dual push-pull silicon N-channel enhancement mode vertical D-MOS transistor encapsulated in a 4-lead, SOT262A1 balanced flange package with two ceramic caps. The mounting flange provides the common source connection for the transistors.

#### CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

#### PINNING - SOT262A1

PIN	DESCRIPTION
1	drain 1
2	drain 2
3	gate 1
4	gate 2
5	source



Fig.1 Simplified outline and symbol.

#### QUICK REFERENCE DATA

RF performance at  $T_h$  = 25 °C in a push-pull common source test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)
CW, class-B	108	50	300	>20	>60
CW, class-C	108	50	300	typ. 18	typ. 80
CW, class-AB	225	50	250	>14 typ. 16	>50 typ. 55

#### WARNING

#### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO discs are not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

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#### LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per transistor	section		·		
V <sub>DS</sub>	drain-source voltage		-	125	V
V <sub>GS</sub>	gate-source voltage		-	±20	V
ID	drain current (DC)		-	18	A
P <sub>tot</sub>	total power dissipation	$T_{mb} \le 25$ °C; total device; both sections equally loaded	-	500	W
T <sub>stg</sub>	storage temperature		-65	150	°C
Tj	junction temperature		-	200	°C

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	total device; both sections equally loaded.	max. 0.35	K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink	total device; both sections equally loaded.	max. 0.15	K/W





(1) Continuous operation.

(2) Short-time operation during mismatch.

Fig.3 Power derating curves.

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#### CHARACTERISTICS

 $T_j$  = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Per transistor	section					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>GS</sub> = 0; I <sub>D</sub> = 100 mA	125	-	_	V
I <sub>DSS</sub>	drain-source leakage current	$V_{GS} = 0; V_{DS} = 50 V$	-	-	2.5	mA
I <sub>GSS</sub>	gate-source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$	-	-	1	μA
V <sub>GSth</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 50 mA	2	-	4.5	V
$\Delta V_{GS}$	gate-source voltage difference of both sections	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 50 mA	-	-	100	mV
<b>g</b> fs	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 5 A	4.5	6.2	_	S
g <sub>fs1</sub> /g <sub>fs2</sub>	forward transconductance ratio of both sections	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 5 A	0.9	-	1.1	
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 5 A	-	0.2	0.3	Ω
I <sub>DSX</sub>	drain cut-off current	V <sub>GS</sub> = 10 V; V <sub>DS</sub> = 10 V	_	25	_	A
C <sub>is</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 50 V; f = 1 MHz	-	480	-	pF
C <sub>os</sub>	output capacitance	$V_{GS} = 0; V_{DS} = 50 V; f = 1 MHz$	-	190	_	pF
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0; V_{DS} = 50 V; f = 1 MHz$	_	14	-	pF
C <sub>d-f</sub>	drain-flange capacitance		-	5.4	-	pF

#### V<sub>GS</sub> group indicator

GROUP		IITS /)	GROUP	LIMITS (V)		
	MIN.	MAX.		MIN.	MAX.	
А	2.0	2.1	0	3.3	3.4	
В	2.1	2.2	Р	3.4	3.5	
С	2.2	2.3	Q	3.5	3.6	
D	2.3	2.4	R	3.6	3.7	
E	2.4	2.5	S	3.7	3.8	
F	2.5	2.6	Т	3.8	3.9	
G	2.6	2.7	U	3.9	4.0	
Н	2.7	2.8	V	4.0	4.1	
J	2.8	2.9	W	4.1	4.2	
К	2.9	3.0	Х	4.2	4.3	
L	3.0	3.1	Y	4.3	4.4	
М	3.1	3.2	Z	4.4	4.5	
Ν	3.2	3.3				

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# Fig.5 Drain current as a function of gate-source voltage; typical values per section.





#### **APPLICATION INFORMATION**

#### **Class-B** operation

RF performance in CW operation in a common source push-pull test circuit. T<sub>h</sub> = 25 °C; R<sub>th mb-h</sub> = 0.15 K/W unless otherwise specified. R<sub>GS</sub> = 4  $\Omega$  per section; optimum load impedance per section = 3.2 + j4.3  $\Omega$  (V<sub>DS</sub> = 50 V).

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	І <sub>DQ</sub> (А)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)
CW, class-B	108	50	2×0.1	300	>20 typ. 22	>60 typ. 70
CW, class-C	108	50	$V_{GS} = 0$	300	typ. 18	typ. 80

#### **Ruggedness in class-B operation**

The BLF278 is capable of withstanding a load mismatch corresponding to VSWR = 7:1 through all phases under the following conditions:  $V_{DS} = 50$  V; f = 108 MHz at rated load power.

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(1)  $T_h = 25 \text{ °C}.$ 

(2) T<sub>h</sub> = 70 °C.

Fig.9 Power gain as a function of load power; typical values.



Fig.11 Load power as a function of input power; typical values.



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<sup>+V</sup>DD1 C20 −**1**|−-**[**€ C16 C21 -**1**|---€ R2 Ь А C12 -**1|--**[€́ L11 R8 R3 C22 ─**1**|---[€ C13 ┨┠─┨┊ C9 ∦**⊣**∣⊢ C17 §**|\_\_|**|\_ L12 R4 D.U.T. ) | L13 L17 L19 L9 C31 L21 50 Ω input -11-L1 L3 L5 L7 C3 H  $\rightarrow$ 50 Ω C33 📥 T1 output R1 ₽ FC5 <sup>₹</sup>C6<sup>†</sup>C7 <u>) L22</u> C27 ₹ 1 C28 C2 C4 C34 🛨 7/7 H₽ L4 L6 L8 L2 -**||** C32 L10 L14 L18 L20 L23 7 R5 L15 MGE688 C10 ₰**──**┃ C23 ─**1**|──**[**] C14 —**1**1—€ C18 ∦\_\_\_||\_ A R6 C15 ─**1**|─**1**| TL16 R9 ± C35 R11 +VDD1 IC1 C24 R7 **+**C36 **+II−i ≠**C11 C19 §**| ||**-C25 −**1**|−−**[**§ <del>7//</del>. ₩. <del>7///</del>. +VDD2 Fig.12 Class-B test circuit at f = 108 MHz.

Philips Semiconductors

VHF push-pull power MOS transistor

Product Specification

**BLF278** 

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#### COMPONENT DESCRIPTION VALUE DIMENSIONS CATALOGUE NO. C1, C2, C33, C34 multilayer ceramic chip capacitor; 22 pF, 500 V note 1 C3, C4 multilayer ceramic chip capacitor; 100 pF + 68 pF note 1 in parallel, 500 V C5, C6, C28 film dielectric trimmer 5 to 60 pF 2222 809 08003 C7 multilayer ceramic chip capacitor; 2 × 100 pF + note 1 $1 \times 120 \text{ pF}$ in parallel, 500 V C8, C11, C12, 100 nF, 500 V 2222 852 47104 multilayer ceramic chip capacitor C15, C16, C19, C36 C9, C10, C13, multilayer ceramic chip capacitor; 1 nF, 500 V C14, C20, C25 note 1 C17, C18, C22, multilayer ceramic chip capacitor; 470 pF, 500 V C23 note 1 C21, C24, C35 electrolytic capacitor 10 µF, 63 V C26 multilayer ceramic chip capacitor; 2 × 15 pF + note 1 $1 \times 18 \text{ pF}$ in parallel, 500 V C27 $3 \times 15 \text{ pF}$ in multilayer ceramic chip capacitor; note 1 parallel, 500 V C29 2×18 pF + multilayer ceramic chip capacitor; note 1 $1 \times 15 \text{ pF}$ in parallel, 500 V C30 film dielectric trimmer 2 to 18 pF 2222 809 09006 C31, C32 multilayer ceramic chip capacitor; $3 \times 43 \text{ pF}$ in note 1 parallel, 500 V L1, L2 stripline; note 2 43 Ω lenath 57.5 mm width 6 mm L3, L4 length 29.5 mm stripline; note 2 43 Ω width 6 mm L5, L6 stripline; note 2 43 Ω length 14 mm width 6 mm L7. L8 stripline; note 2 43 Ω length 6 mm width 6 mm L9, L10 stripline; note 2 43 Ω length 17.5 mm width 6 mm L11, L16 $2 \times$ grade 3B Ferroxcube wideband 4312 020 36642 HF chokes in parallel L12, L15 4 turns enamelled 2 mm copper wire 85 nH length 13.5 mm int. dia. 10 mm leads $2 \times 7$ mm L13, L14 stripline; note 2 43 Ω length 19.5 mm

#### List of components (see Figs 12 and 13).

width 6 mm

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COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
L17, L18	stripline; note 2	43 Ω	length 24.5 mm width 6 mm	
L19, L20	stripline; note 2	43 Ω	length 66 mm width 6 mm	
L21, L23	stripline; note 2	50 Ω	length 160 mm width 4.8 mm	
L22	semi-rigid cable; note 3	50 Ω	ext. dia. 3.6 mm outer conductor length 160 mm	
R1	metal film resistor	10 Ω, 0.4 W		
R2, R7	10 turn potentiometer	50 kΩ		
R3, R6	metal film resistor	$3 \times 12.1 \Omega$ in parallel, 0.4 W		
R4, R5	metal film resistor	10 Ω; 0.4 W		
R8, R9	metal film resistor	10 Ω ±5%, 1 W		
R10	metal film resistor	$4 \times 10 \ \Omega$ in parallel, 1 W		
R11	metal film resistor	5.11 kΩ, 1 W		
IC1	voltage regulator 78L05			
T1	1:1 Balun; 7 turns type 4C6 50 $\Omega$ coaxial cable wound around toroid		$14 \times 9 \times 5 \text{ mm}$	4322 020 90770

#### Notes

1. American Technical Ceramics capacitor, type 100B or capacitor of same quality.

2. L1 to L10, L13, L14, L17 to L21 and L23 are striplines on a double copper-clad printed-circuit board, with fibre-glass PTFE dielectric ( $\epsilon_r$  = 2.2), thickness <sup>1</sup>/<sub>16</sub> inch; thickness of copper sheet 2 × 35 µm.

3. L22 is soldered on to stripline L21.



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Class-B operation; V<sub>DS</sub> = 50 V; I<sub>DQ</sub> = 2 × 0.1 A; R<sub>GS</sub> = 4  $\Omega$  (per section); P<sub>L</sub> = 300 W.

Fig.15 Load impedance as a function of frequency (series components); typical values per section.





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#### **Class-AB** operation

RF performance in CW operation in a common source push-pull test circuit. T<sub>h</sub> = 25 °C; R<sub>th mb-h</sub> = 0.15 K/W unless otherwise specified. R<sub>GS</sub> = 2.8  $\Omega$  per section; optimum load impedance per section = 0.74 + j2  $\Omega$ ; (V<sub>DS</sub> = 50 V).

MODE OF OPERATION	f	V <sub>DS</sub>	I <sub>DQ</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>
	(MHz)	(V)	(A)	(W)	(dB)	(%)
CW, class-AB	225	50	2×0.5	250	>14 typ. 16	>50 typ. 55

#### **Ruggedness in class-AB operation**

The BLF278 is capable of withstanding a load mismatch corresponding to VSWR = 7:1 through all phases under the following conditions:  $V_{DS}$  = 50 V; f = 225 MHz at rated output power.

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Class-AB operation;  $V_{DS} = 50$  V;  $I_{DQ} = 2 \times 0.5$  A; f = 225 MHz;  $Z_L = 0.74 + j2 \Omega$  (per section);  $R_{GS} = 2.8 \Omega$  (per section). (1)  $T_h = 25 \text{ °C}$ . (2)  $T_h = 70 \text{ °C}$ .

## Fig.18 Power gain as a function of load power; typical values.





Fig.19 Efficiency as a function of load power; typical values.

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Product Specification

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#### DIMENSIONS COMPONENT DESCRIPTION VALUE CATALOGUE NO. C1, C2 multilayer ceramic chip capacitor; 27 pF, 500 V note 1 C3, C4, C31, C32 multilayer ceramic chip capacitor; $3 \times 18 \text{ pF}$ note 1 in parallel, 500 V C5 film dielectric trimmer 4 to 40 pF 2222 809 08002 C6, C30 film dielectric trimmer 2 to 18 pF 2222 809 09006 100 pF, 500 V C7 multilayer ceramic chip capacitor; note 1 C8, C9, C15, C18 MKT film capacitor 1 μF, 63 V 2222 371 11105 C10, C13, C14, multilayer ceramic chip capacitor 100 nF, 50 V 2222 852 47104 C19, C36 C11, C12 multilayer ceramic chip capacitor; $2 \times 1$ nF in parallel, note 1 500 V C16, C17 electrolytic capacitor 220 µF, 63 V C20 multilayer ceramic chip capacitor: $3 \times 33$ pF in parallel, 500 V note 1 C21 film dielectric trimmer 2 to 9 pF 2222 809 09005 C22, C27, C37, multilayer ceramic chip capacitor; 1 nF, 500 V C38 note 1 C23, C26, C35 electrolytic capacitor 10 µF, 63 V C24, C25 multilayer ceramic chip capacitor; $2 \times 470 \text{ pF}$ in parallel, 500 V note 1 C28 2×10 pF + multilayer ceramic chip capacitor; note 1 $1 \times 18 \text{ pF}$ in parallel, 500 V C29 $2 \times 5.6 \text{ pF}$ in multilayer ceramic chip capacitor; parallel, 500 V note 1 C33, C34 multilayer ceramic chip capacitor; 5.6 pF, 500 V note 1 length 80 mm L1, L3, L22, L24 stripline; note 2 **50** Ω width 4.8 mm ext. dia. 3.6 mm L2, L23 semi-rigid cable; note 3 50 Ω outer conductor length 80 mm length 24 mm L4, L5 stripline; note 2 43 Ω width 6 mm L6, L7 stripline; note 2 $43 \Omega$ length 14.5 mm width 6 mm L8, L9 stripline; note 2 43 Ω length 4.4 mm width 6 mm L10, L11 stripline; note 2 length 3.2 mm 43 Ω width 6 mm L12, L13 stripline; note 2 43 Ω length 15 mm width 6 mm

#### List of components (see Figs 21 and 22).

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COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
L14, L17	$2 \times$ grade 3B Ferroxcube wideband HF chokes in parallel			4312 020 36642
L15, L16	$1\frac{3}{4}$ turns enamelled 2 mm copper wire	40 nH	int. dia. 10 mm leads $2 \times 7$ mm space 1 mm	
L18, L19	stripline; note 2	43 Ω	length 13 mm width 6 mm	
L20, L21	stripline; note 2	43 Ω	length 29.5 mm width 6 mm	
R1	metal film resistor	10 Ω, 0.4 W		
R2, R7	10 turns potentiometer	50 kΩ		
R3, R6	metal film resistor	1 kΩ, 0.4 W		
R4, R5	metal film resistor	$2 \times 5.62 \Omega$ , in parallel, 0.4 W		
R8, R9	metal film resistor	10 Ω ±5%, 1 W		
R10	metal film resistor	$4 \times 42.2 \Omega$ in parallel, 1 W		
R11	metal film resistor	5.11 kΩ, 1 W		
IC1	voltage regulator 78L05			

#### Notes

- 1. American Technical Ceramics capacitor, type 100B or other capacitor of the same quality.
- 2. L1, L3 to L13, L18 to L22 and L24 are microstriplines on a double copper-clad printed-circuit board, with fibre-glass reinforced PTFE dielectric ( $\epsilon_r = 2.2$ ), thickness  $\frac{1}{16}$  inch; thickness of copper sheet 2 × 35 µm.
- 3. L2 and L23 are soldered on to striplines L1 and L24 respectively.



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Class-AB operation; V\_{DS} = 50 V; I\_{DQ} = 2 \times 0.5 A; R\_{GS} = 2.8 \ \Omega (per section); PL = 250 W.

Fig.24 Load impedance as a function of frequency (series components); typical values per section.



#### **BLF278 scattering parameters**

 $V_{DS} = 50 \text{ V}; I_{D} = 500 \text{ mA}; \text{ note } 1$ 

f (MHz)		s <sub>11</sub>	S	21	S	12	s	S <sub>22</sub>	
	s <sub>11</sub>	$\angle \Phi$	s <sub>21</sub>	$\angle \Phi$	s <sub>12</sub>	$\angle \Phi$	s <sub>22</sub>	$\angle \Phi$	
5	0.87	-142.1	60.05	104.3	0.00	-19.4	0.83	160.9	
10	0.88	-159.8	32.09	91.4	0.00	0.68	167.5	165.8	
20	0.88	-169.0	15.70	77.3	0.01	13.4	0.62	177.6	
30	0.88	-171.2	9.98	68.4	0.01	3.4	0.64	-175.8	
40	0.89	-172.2	6.99	61.0	0.01	-4.4	0.66	-171.2	
50	0.91	-172.9	5.24	55.0	0.01	-10.3	0.70	-168.1	
60	0.92	-173.5	4.08	49.6	0.01	-15.0	0.74	-166.8	
70	0.93	-174.1	3.26	44.9	0.01	-18.3	0.78	-166.5	
80	0.94	-174.7	2.66	41.0	0.01	-19.8	0.80	-166.5	
90	0.95	-175.2	2.22	37.5	0.00	-19.7	0.83	-166.7	
100	0.95	-175.7	1.88	34.0	0.00	-18.0	0.85	-167.4	
125	0.97	-176.9	1.27	26.8	0.00	-1.9	0.88	-169.4	
150	0.97	-177.9	0.91	22.7	0.00	35.3	0.91	-170.0	
175	0.98	-178.7	0.69	19.5	0.00	65.3	0.94	-170.8	
200	0.98	-179.5	0.54	16.0	0.00	78.0	0.95	-172.4	
250	0.99	179.2	0.35	12.1	0.01	86.7	0.96	-174.0	
300	0.99	178.1	0.25	9.1	0.01	87.8	0.98	-175.5	
350	0.99	177.1	0.19	8.2	0.01	90.3	0.98	-176.5	
400	0.99	176.1	0.14	7.2	0.01	91.4	0.99	-177.6	
450	0.99	175.1	0.11	8.1	0.02	92.2	0.99	-178.3	
500	0.99	174.2	0.09	9.7	0.02	91.5	0.99	-179.2	
600	0.99	172.4	0.07	14.8	0.02	91.4	0.99	179.5	
700	0.99	170.7	0.05	24.0	0.03	91.6	0.99	178.3	
800	0.99	168.9	0.04	35.6	0.03	92.5	1.00	177.1	
900	0.99	167.1	0.04	46.0	0.04	93.1	1.00	176.0	
1000	0.99	165.2	0.04	60.3	0.04	94.1	1.00	175.0	

#### Note

1. For more extensive s-parameters see internet:

http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast.

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### VHF push-pull power MOS transistor

#### PACKAGE OUTLINE





SOT262A1

**BLF278** 

#### DATA SHEET STATUS

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)(3)</sup>	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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#### Notes

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- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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